

Search Notes

Application/Control No.

10/810,749

Examiner

Hien N. Nguyen

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2824

SEARCHED

Class	Subclass	Date	Examiner
365	222	8/25/2005	HN
365	205	↓	HN
365	207		HN
365	194		HN
365	230.03		HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
365	205	9/6/2005	HN
365	207	9/6/2005	HN
365	222	9/6/2005	HN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	8/25/2005	HN